

| | | | |
|-----------------------------------|---------------------------------------|--|-------------|
| Notice of References Cited | Application/Control No. 10/814,415 | Applicant(s)/Patent Under Reexamination HERNANDEZ ET AL. | |
| | Examiner LEE D. WILSON | Art Unit 3723 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------------|----------------|
| * | A | US-6,416,039 b1 | 07-2002 | Pietrusynski, Martin S. | 254/8B |
| * | B | US-us00d468512s | 07-2003 | HERNANDEZ | D34/28 |
| * | C | US-6,769,668 b2 | 08-2004 | Siglock, John V. | 254/124 |
| * | D | US-5,732,931 | 03-1998 | Massel, Bruno H. | 254/8B |
| * | E | US-7,004,454 b2 | 02-2006 | Petrone et al. | 254/10R |
| * | F | US-5,269,501 a | 12-1993 | Liegel et al. | 269/17 |
| * | G | US-6,390,451 b1 | 05-2002 | Baker, Wayne F. | 254/94 |
| * | H | US-2005/0218384 a1 | 10-2005 | Hernandez et al. | 254/010.00B |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.